

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10552705	SHIBAYAMA ET AL.
	Examiner	Art Unit
	DAVID S BAKER	2884

SEARCHED

Class	Subclass	Date	Examiner
250	370.11	16 NOV 08	DSB
250	371	16 NOV 08	DSB

SEARCH NOTES

Search Notes	Date	Examiner
See attached EAST Search History	16 NOV 08	DSB
Consultation: Examiner Christine Sung AU 2884	16 NOV 08	DSB

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
ALL	ALL; Search Terms: "(signal WITH process\$5).clm. AND (through WITH hole) AND shield\$5 AND (glass WITH substrate).clm."	16 NOV 08	DSB
250	ALL; Search Terms: "(signal WITH process\$5).clm. AND (through WITH hole) AND shield\$5 AND (glass WITH substrate).clm."	16 NOV 08	DSB
ALL	ALL; Search Terms: "(signal WITH process\$5).clm. AND (through WITH hole) AND (glass WITH substrate).clm."	16 NOV 08	DSB
250	ALL; Search Terms: "(signal WITH process\$5).clm. AND (through WITH hole) AND (glass WITH substrate).clm."	16 NOV 08	DSB
ALL	ALL; Search Terms: "(signal WITH process\$5).clm. AND (through WITH hole) AND shield\$5"	16 NOV 08	DSB
250	ALL; Search Terms: "(signal WITH process\$5).clm. AND (through WITH hole) AND shield\$5"	16 NOV 08	DSB

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